XRD Lattice Parameter



Why are $K\alpha_1$ and $K\alpha_2$ peaks resolved at high angles?

Which 'Line' to use for lattice parameter calculation?

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- \Box At higher Bragg angles the K α_1 and K α_2 lines are resolved (reason shown in the next slide)
- \Box Typically we use only the K α_1 lines for the calculation of lattice parameter
- □ The error in the calculation of lattice parameter decreases with increasing angle
 → hence the high angle peaks should be used for lattice parameter calculation (instead of taking an average over all peaks or taking any of the intense low angle peaks)



Why are $K\alpha_1$ and $K\alpha_2$ peaks resolved at high angles?

- □ The K α_1 (Cu_{K α_1} = 1.540598 Å) and K α_2 (Cu_{K α_2} = 1.54439 Å) lines differ slightly in wavelength. Hence, in principle two separate peaks should be seen in the diffraction pattern.
- □ Usually, at low angles these peaks are merged (i.e. seen as a single peak) and at high angles these peaks are resolved (seen as two separate peaks). *The question is why?*
- This can be understood in terms of the variation of θ with λ (as in this case λ is not fixed) and the graphical (Ewald sphere) construction (upcoming slides).





Actually, the variation in 2θ is to be seen

Which 'Line' to use for lattice parameter calculation?

- Typically we use only the $K\alpha_1$ lines for the calculation of lattice parameter. And this can be done at high angles as the $K\alpha_1 \& K\alpha_2$ lines are resolved at high angles.
- □ The error in the calculation of lattice parameter decreases with increasing angle → hence the high angle peaks should be used for lattice parameter calculation (instead of taking an average over all peaks or taking any of the intense low angle peaks) (as shown in slides to follow).



Let us calculate the error in d spacing as a function of the angle of diffraction







Error in d spacing decreases with θ

 \rightarrow hence high angle peaks have to be used for lattice parameter calculation



Determination of Lattice parameter from 2θ versus Intensity Data

n	20	θ	Sinθ	Sin ² θ	ratio	Index	a (nm)	
1	38.52	19.26	0.33	0.11	3	111	0.40448	
2	44.76	22.38	0.38	0.14	4	200	0.40457	
3	65.14	32.57	0.54	0.29	8	220	0.40471	
4	78.26	39.13	0.63	0.40	11	311	0.40480	
5*	82.47	41.235	0.66	0.43	12	222	0.40480	
6*	99.11	49.555	0.76	0.58	16	400	0.40485	
7*	112.03	56.015	0.83	0.69	19	331	0.40491	
8*	116.60	58.3	0.85	0.72	20	420	0.40491	
9*	137.47	68.735	0.93	0.87	24	422	0.40494	

* $\rightarrow \alpha_1$, α_2 peaks are resolved (α_1 peaks are listed)

$$1.54 = 2 d_{422} \sin \theta_{422} = 2 \frac{a}{\sqrt{24}} 0.93$$

Others methods exist for precise lattice parameter measurement (than just taking a single value)!

 $a_{Calculated from the 422 line} = 4.0494 \text{ \AA}$



References:

MATERIALS SCIENCE & ENGINEERING: A Learner's Guíde, Anandh Subramaniam, http://home.iitk.ac.in/~anandh/E-book.htm.

